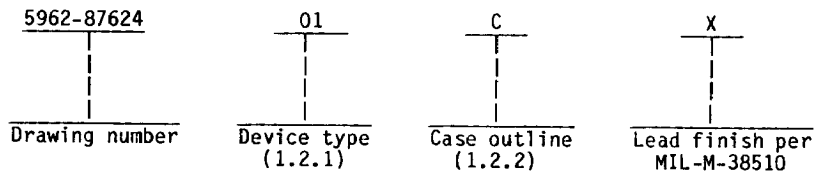


1. SCOPE

1.1 Scope. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 Part number. The complete part number shall be as shown in the following example:



1.2.1 Device type. The device type shall identify the circuit function as follows:

<u>Device type</u>	<u>Generic number</u>	<u>Circuit function</u>	Hex	Handwritten
01	54AC14	Hex inverter Schmidt trigger		Schmitt trigger inverter

1.2.2 Case outlines. The case outlines shall be as designated in appendix C of MIL-M-38510, and as follows:

<u>Outline letter</u>	<u>Case outline</u>
C	D-1 (14-lead, 1/4" x 3/4") dual-in-line package
D	F-2 (14-lead, 1/4" x 3/8") flat package
2	C-2 (20-terminal, .350" x .350") square chip carrier package

1.3 Absolute maximum ratings.

Supply voltage range	1/-	- - - - -	-0.5 V dc to +6.0 V dc
DC input voltage	1/-	- - - - -	-0.5 V dc to $V_{CC} + 0.5$ V dc
DC output voltage	1/-	- - - - -	-0.5 V dc to $V_{CC} + 0.5$ V dc
Clamp diode current-	-	- - - - -	± 20 mA
DC output current (per pin)-	-	- - - - -	± 50 mA
DC V_{CC} or GND current (per pin)-	-	- - - - -	± 100 mA
Storage temperature range-	-	- - - - -	-65°C to $+150^{\circ}\text{C}$
Maximum power dissipation (P_D)	-	- - - - -	500 mW
Lead temperature (soldering, 10 seconds)	-	- - - - -	$+245^{\circ}\text{C}$
Thermal resistance, junction-to-case (θ_{JC}):			
Cases C and D-	-	- - - - -	(See MIL-M-38510, appendix C)
Case 2	-	- - - - -	60°C/W <u>2/</u>
Junction temperature (T_J)	3/-	- - - - -	$+175^{\circ}\text{C}$

- 1/ Unless otherwise specified, all voltages are referenced to GND.
- 2/ When thermal resistance value is included in MIL-M-38510, appendix C, it shall supersede the value stated herein.
- 3/ Maximum junction temperature shall not be exceeded except for allowable short duration burn-in screening conditions in accordance with method 5004 of MIL-STD-883.

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1.4 Recommended operating conditions.

Supply voltage (V_{CC}) 4/ - - - - - 3.0 V dc to 5.5 V dc
Input voltage- - - - - 0.0 V dc to V_{CC}
Output voltage - - - - - 0.0 V dc to V_{CC}
Case operating temperature range (T_C) - - - - - -55°C to $+125^{\circ}\text{C}$

2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

3. REQUIREMENTS

3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.

3.2.1 Terminal connections and logic diagram. The terminal connections and logic diagram shall be as specified on figure 1.

3.2.2 Truth table. The truth table shall be as specified on figure 2.

3.2.3 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.

3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full recommended case operating temperature range.

4/ Operation from 2.0 V dc to 3.0 V dc is provided for compatibility with data retention and battery backup systems. Data retention implies no input transition and no stored data loss with the following conditions:

$V_{IH} \geq 70\% V_{CC}$, $V_{IL} \leq 30\% V_{CC}$, $V_{OH} \geq 70\% V_{CC} @ -20 \mu\text{A}$, $V_{OL} \leq 30\% V_{CC} @ 20 \mu\text{A}$.

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TABLE 1. Electrical performance characteristics.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C		Group A subgroups	Limits		Unit
					Min	Max	
High-level output voltage <u>1/</u>	V _{OH}	V _{IN} = V _{IH} or V _{IL} I _{OH} = -50 uA	V _{CC} = 3.0 V	1,2,3	2.9		V
			V _{CC} = 4.5 V		4.4		
			V _{CC} = 5.5 V		5.4		
		V _{IN} = V _{IH} or V _{IL} I _{OH} = -4 mA	V _{CC} = 3.0 V		2.4		
			V _{CC} = 4.5 V		3.7		
					V _{CC} = 5.5 V	4.7	
		V _{IN} = V _{IH} or V _{IL} I _{OH} = -50 mA	V _{CC} = 5.5 V		3.85		
Low-level output voltage <u>1/</u>	V _{OL}	V _{IN} = V _{IH} or V _{IL} I _{OL} = 50 μA	V _{CC} = 3.0 V	1,2,3		0.1	V
			V _{CC} = 4.5 V			0.1	
			V _{CC} = 5.5 V			0.1	
		V _{IN} = V _{IH} or V _{IL} I _{OL} = 12 mA	V _{CC} = 3.0 V			0.5	
			V _{CC} = 4.5 V			0.5	
					V _{CC} = 5.5 V		
		V _{IN} = V _{IH} or V _{IL} I _{OL} = 50 mA	V _{CC} = 5.5 V			1.65	
High-level input voltage <u>2/</u>	V _{IH}		V _{CC} = 3.0 V		2.1		V
			V _{CC} = 4.5 V		3.15		
			V _{CC} = 5.5 V		3.85		
Low-level input voltage <u>2/</u>	V _{IL}		V _{CC} = 3.0 V			0.9	V
			V _{CC} = 4.5 V			1.35	
			V _{CC} = 5.5 V			1.65	
Input leakage current	I _{IL}	V _M = 0.0 V	V _{CC} = 5.5 V	1,2,3		-1.0	μA
	I _{IH}	V _M = 5.5 V				1.0	

See footnotes at end of table.

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TABLE I. Electrical performance characteristics - Continued.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C	Group A subgroups	Limits		Unit		
				Min	Max			
Quiescent current	I _{CCH}	V _{IN} = V _{CC} or GND V _{CC} = 5.5 V	1,2,3		80	μA		
	I _{CCL}				80			
Input capacitance	C _{IN}	See 4.3.1c	4		8.0	pF		
Power dissipation 3/ capacitance	C _{PD}	See 4.3.1c	4		40	pF		
Functional tests		Tested at V _{CC} = 3.0 V and repeated at V _{CC} = 5.5 V, see 4.3.1d	7,8					
Propagation delay time High to low Low to high In to Qn 4/	t _{PHL}	T _C = +25°C C _L = 50 pF R _L = 500Ω See figure 3	V _{CC} = 3.0 V	9	1.0	11.5	ns	
			V _{CC} = 4.5 V		1.0	8.5		
			V _{CC} = 3.0 V		1.0	13.5		
			V _{CC} = 4.5 V		1.0	10.0		
	t _{PLH}	T _C = -55°C and +125°C C _L = 50 pF R _L = 500Ω See figure 3	V _{CC} = 3.0 V	10,11	1.0	14.0	ns	
			V _{CC} = 4.5 V			1.0		10.0
			V _{CC} = 3.0 V			1.0		16.0
			V _{CC} = 4.5 V			1.0		12.0

- 1/ V_{OH} and V_{OL} tests will be tested at $V_{CC} = 3.0\text{ V}$ and $V_{CC} = 4.5\text{ V}$. All other voltages are guaranteed if not tested. Limits shown apply to operation at $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ and $V_{CC} = 5.0\text{ V} \pm 0.5\text{ V}$. Transmission driving tests are performed at $V_{CC} = 5.5\text{ V}$ with a 2 ms duration maximum.
- 2/ V_{IH} and V_{IL} tests are guaranteed by the V_{OH} and V_{OL} tests.
- 3/ Power dissipation capacitance (C_{PD}), determines the dynamic power consumption, $P_D = (C_{PD} + C_D) V_{CC}^2 f + I_{CC} V_{CC}$, and the dynamic current consumption (I_S) is, $I_S = (C_{PD} + C_D) V_{CC} f + I_{CC}$.
- 4/ AC limits at $5.5\text{ V } V_{CC}$ are equal to limits at $4.5\text{ V } V_{CC}$ and guaranteed by testing at $4.5\text{ V } V_{CC}$. Minimum ac guaranteed for $5.5\text{ V } V_{CC}$ by guardbanding $4.5\text{ V } V_{CC}$ limits to 1.5 ns minimum.

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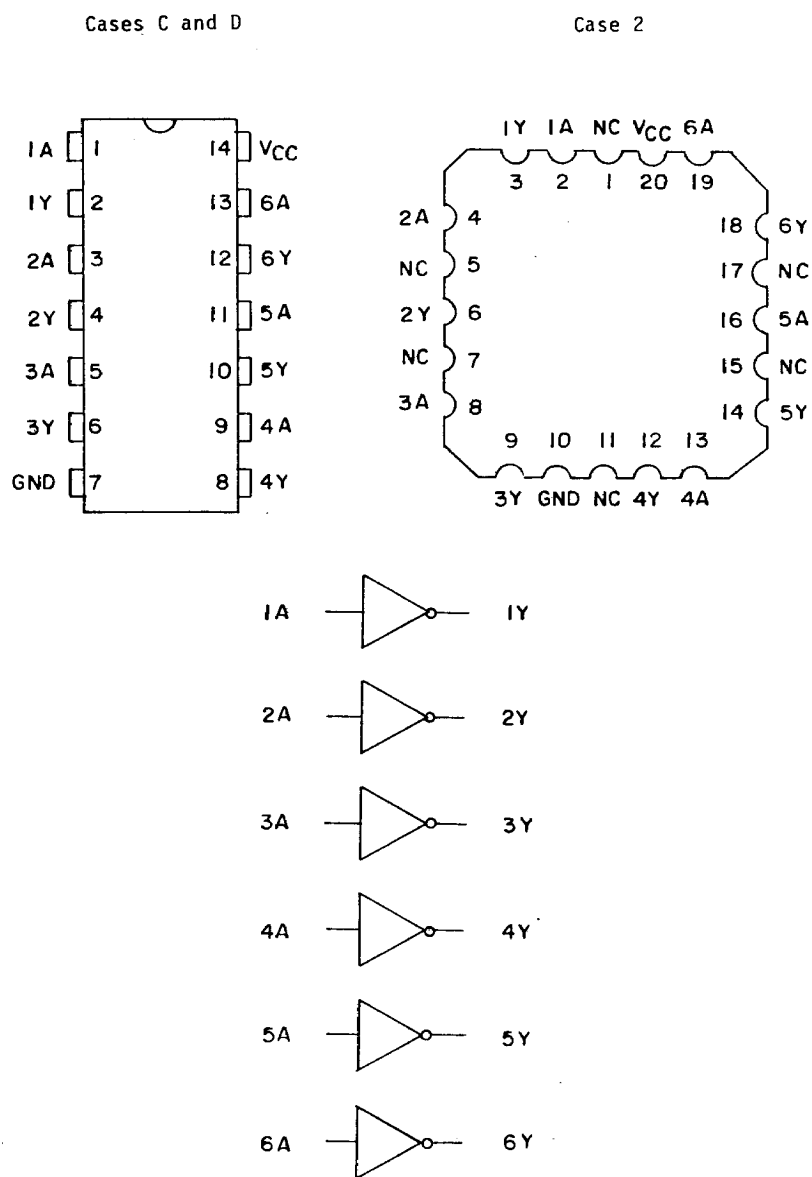
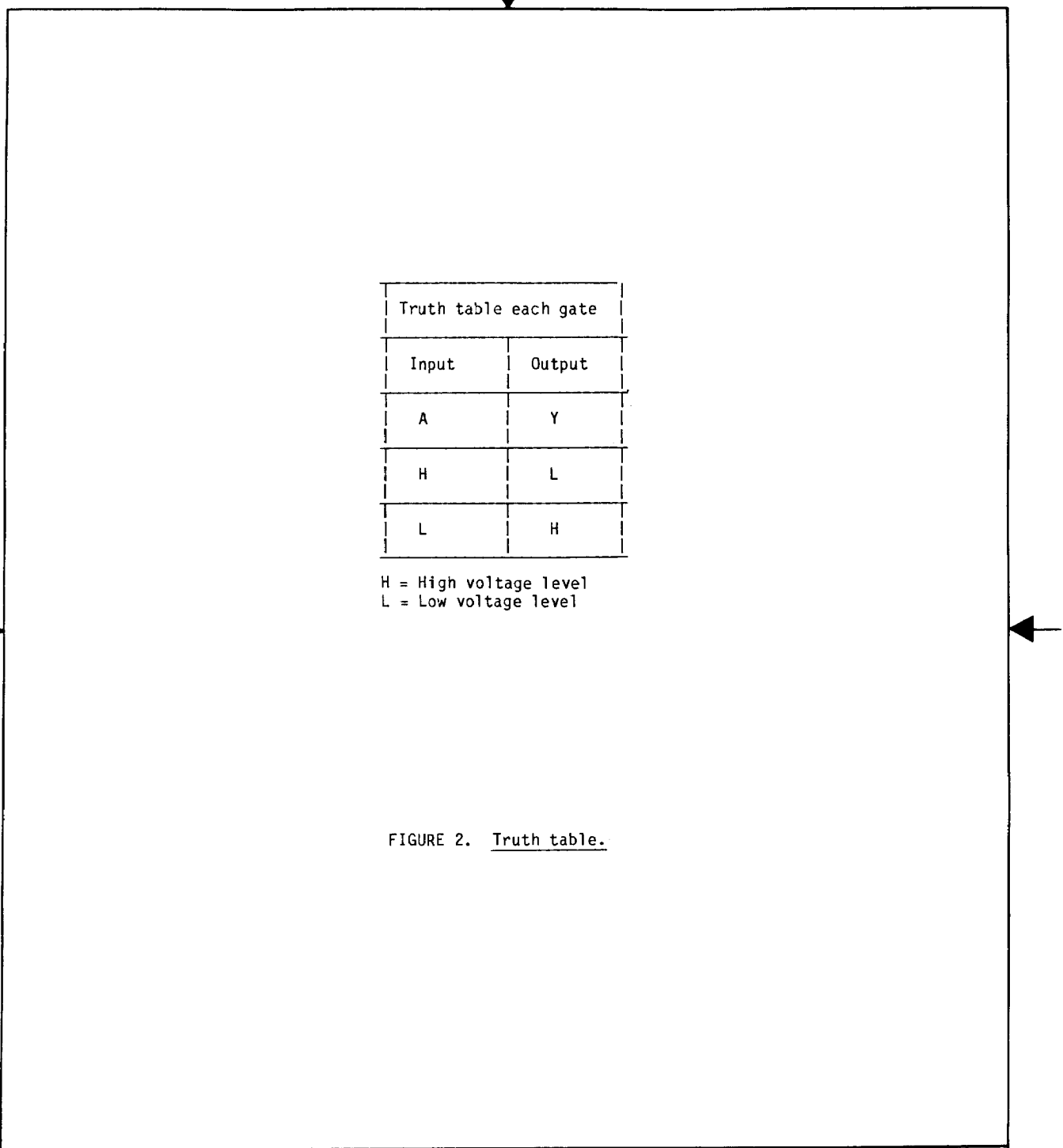


FIGURE 1. Logic diagram and terminal connections.

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Truth table each gate	
Input	Output
A	Y
H	L
L	H

H = High voltage level
L = Low voltage level

FIGURE 2. Truth table.

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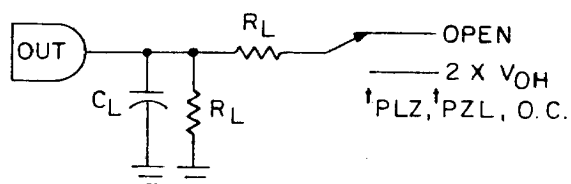
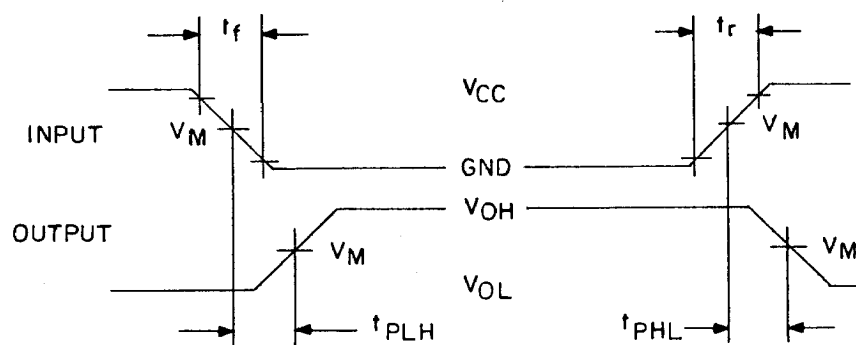
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NOTES:

1. $t_r = t_f = 3.0 \text{ ns}$, 10% to 90% or equivalent.
2. Measure voltage (V_M) = 50% of V_{CC} .
3. $R_L = 500 \text{ ohms}$, $C_L = 50 \text{ pF}$ or equivalent.

FIGURE 3. Switching waveforms.

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3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.

3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.

3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).

3.8 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

4. QUALITY ASSURANCE PROVISIONS

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).

4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

a. Burn-in test (method 1015 of MIL-STD-883).

(1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).

(2) $T_A = +125^{\circ}\text{C}$, minimum.

b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

4.3.1 Group A inspection.

a. Tests shall be as specified in table II herein.

b. Subgroups 5 and 6 in table I, method 5005 of MIL-STD-883 shall be omitted.

c. Subgroup 4 (C_{IN} and C_{PD} measurements) shall be measured only for the initial test and after process or design changes which may affect capacitance.

d. Subgroups 7 and 8 test sufficiently to verify the truth table.

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	---
Final electrical test parameters (method 5004)	1*,2,3,7,8,9
Group A test requirements (method 5005)	1,2,3,4,7,8, 9,10,11
Groups C and D end-point electrical parameters (method 5005)	1,2,3
Additional electrical subgroups for group C periodic inspections	---

*PDA applies to subgroup 1.

4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test (method 1005 of MIL-STD-883) conditions:
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
 - (2) $T_A = +125^{\circ}\text{C}$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

6.2 Replaceability. Replaceability is determined as follows:

- a. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- b. When a QPL source is established, the part numbered device specified in this drawing will be replaced by the microcircuit identified as part number M38510/75702---.

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6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

6.4 Approved source of supply. An approved source of supply is listed herein. Additional sources will be added as they become available. The vendor listed herein has agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor CAGE number	Vendor similar part number 1/	Replacement military specification part number
5962-8762401CX	07263	54AC14 DMQB	M38510/75702BCX
5962-8762401DX		54AC14 FMQB	
5962-87624012X		54AC14 LMQB	M38510/75702B2X

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE
number

07263

Vendor name
and address

Fairchild Semiconductor
333 Western Avenue
South Portland, ME 04106

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